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| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination JACKSON ET AL. | |
| | | Examiner Laura E. Martin | Art Unit 2853 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|-------------------|----------------|
| * | A | US-2002/0129739 | 09-2002 | Yanagimoto et al. | 106/410 |
| * | B | US-5,188,891 | 02-1993 | Takeda et al. | 428/323 |
| * | C | US-2002/0044187 | 04-2002 | Koitabashi et al. | 347/101 |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
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| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|-------------------------------------------------------------------------------------------|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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